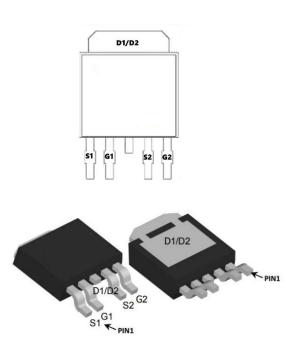




## **Description**

The SX80H03GD uses advanced trench technology to provide excellent R<sub>DS(ON)</sub>, low gate charge and operation with gate voltages as low as 4.5V. This device is suitable for use as a Battery protection or in other Switching application.



#### **General Features**

V<sub>DS</sub> = 30V I<sub>D</sub> =80A

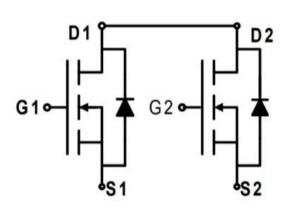
 $R_{DS(ON)} < 5.5 m\Omega$  @  $V_{GS}=10V$ 

## **Application**

Battery protection

Load switch

Uninterruptible power supply



Absolute Maximum Ratings (T<sub>c</sub>=25°Cunless otherwise noted)

Symbol	Parameter	Rating	Units
V <sub>DS</sub>	Drain-Source Voltage	30	V
Vgs	Gate-Source Voltage	±20	V
lo@Tc=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	80	A
lo@Tc=100°C	Continuous Drain Current, V <sub>GS</sub> @ 10V¹	51	А
<b>l</b> o@Ta=25°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	15	А
lo@Ta=70°C	Continuous Drain Current, V <sub>GS</sub> @ 10V <sup>1</sup>	12	А
Ідм	Pulsed Drain Current <sup>2</sup>	160	А
EAS	Single Pulse Avalanche Energy³	115.2	mJ
las	Avalanche Current	48	A
P <b></b> ₀@Tc=25°C	Total Power Dissipation <sup>4</sup>	59	W
P <b>o@T</b> a=25°C	Total Power Dissipation <sup>4</sup>	2	W
Тѕтс	Storage Temperature Range	-55 to 150	℃
TJ	Operating Junction Temperature Range	-55 to 150	℃
RөJA	Thermal Resistance Junction-Ambient <sup>1</sup>	62	°C/W
Rejc	Thermal Resistance Junction-Case <sup>1</sup>	2.1	°C/W

1





Electrical Characteristics (T<sub>J</sub>=25℃, unless otherwise noted)

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Symbol	Parameter	Test Condition	Min.	Тур.	Max.	Units
V(BR)DSS	Drain-Source Breakdown Voltage	Vgs=0V, Ip=250µA	30	32	_	V
△BVDSS/△TJ	BVDSS Temperature Coefficient	Reference to 25℃, ID=1mA		0.028		V/℃
VGS(th)	Gate Threshold Voltage	Vos= Vos, Io=250µA	1.0	1.6	2.5	V
RDS(on)	Static Drain-Source on-Resistance note3	Vgs =10V, ID =30A	-	4.5	5.5	mΩ
RDS(on)	Static Drain-Source on-Resistance note3	Vgs =4.5V, ID =20A	_	6.7	9.5	mΩ
IDSS	Zero Gate Voltage Drain Current	V <sub>DS</sub> =30V, V <sub>GS</sub> = 0V,	-	_	1.0	μA
IGSS	Gate to Body Leakage Current	V <sub>DS</sub> =0V, V <sub>GS</sub> = ±20V	-	_	±100	nA
Ciss	Input Capacitance		-	2100	-	pF
Coss	Output Capacitance	V <sub>DS</sub> =15V, V <sub>GS</sub> =0V, f = 1.0MHz	_	326	_	pF
Crss	Reverse Transfer Capacitance	1 1.51/11.12	_	282	-	pF
$\mathbf{Q}_{\mathrm{g}}$	Total Gate Charge	V <sub>DS</sub> =15V, l <sub>D</sub> =30A, V <sub>GS</sub> =10V	_	45	_	nC
Qgs	Gate-Source Charge		-	3	-	nC
Qgd	Gate-Drain("Miller") Charge		_	15	_	nC
td(on)	Turn-on Delay Time	V <sub>DS</sub> =15V, lo=30A, R <sub>GEN</sub> =3Ω,	_	21	_	ns
<b>t</b> r	Turn-on Rise Time		-	32	-	ns
td(off)	Turn-off Delay Time	Vgs =10V	-	59	-	ns
tf	Turn-off Fall Time		-	34	_	ns
IS	Maximum Continuous Drain to Source Diode Forward Current		_	_	90	Α
ISM	Maximum Pulsed Drain to Source Diode Forward Current		-	-	360	Α
VSD	Drain to Source Diode Forward Voltage	V <sub>G</sub> s = 0V, I <sub>S</sub> =30A	_	-	1.2	V
trr	Body Diode Reverse Recovery Time	1 000 -11/-14 4000 /	-	15	-	ns
Qrr	Body Diode Reverse Recovery Charge	l=20A,dI/dt=100A/μs	_	4	_	nC

#### Note:

- 1. The data tested by surface mounted on a 1 inch2 FR-4 board with 2OZ copper.
- $\mathbf{2}_{\times}$  The data tested by pulsed , pulse width .The EAS data shows Max. rating .
- 3. The test cond≤ 300us , duty cycle ition is VDD=25V,VGS =10V,L=0.1mH,IAS=53.8A
- 5. The data is theoretically the same as ID and IDM , in real applications , should be limited by total power dissipation.

2



## **Typical Characteristics**

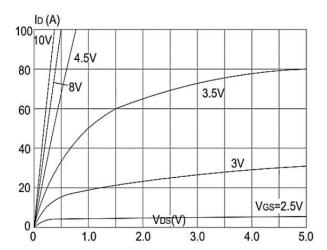


Figure1: Output Characteristics

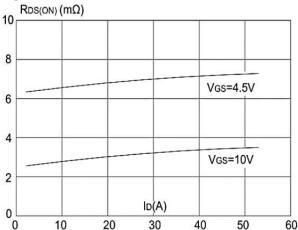


Figure 3:On-resistance vs. Drain Current

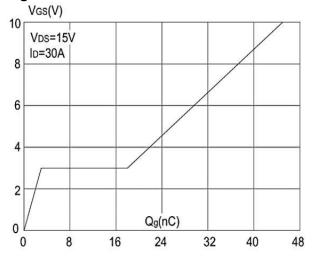
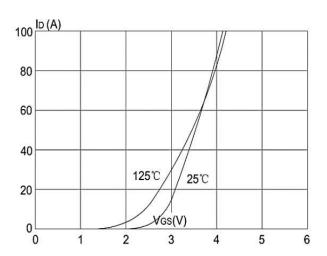


Figure 5: Gate Charge Characteristics



**Figure 2: Typical Transfer Characteristics** 

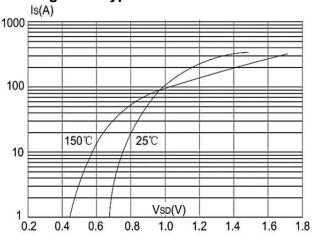


Figure 4: Body Diode Characteristics

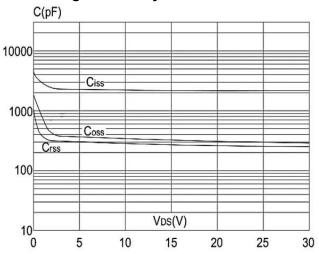


Figure 6: Capacitance Characteristics



# **Typical Characteristics**

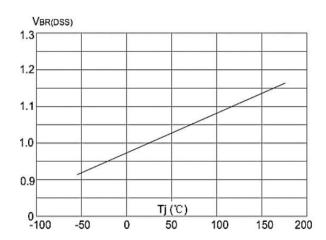


Figure 7: Normalized Breakdown Voltage vs. Junction Temperature

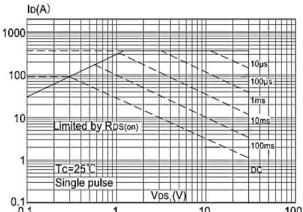


Figure 9: Maximum Safe Operating Area vs. Case Temperature

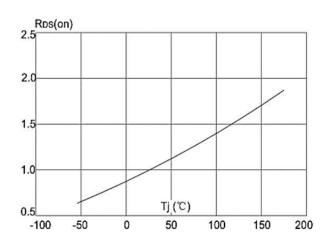
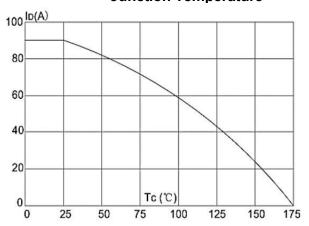


Figure 8: Normalized on Resistance vs Junction Temperature



**Figure 10: Maximum Continuous Drain Current** 

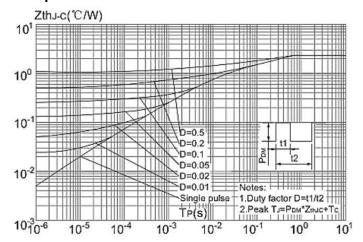
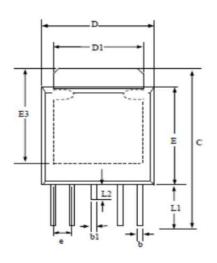
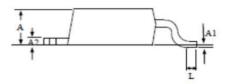


Figure.11: Maximum Effective Transient Thermal Impedance, Junction-to-Case



# **Package Mechanical Data**





SYMBOLS	Millimeters			
JIMDOLS	MIN	NOM	MAX	
D	6.30	6.55	6.80	
Dl	4.80	5.35	5.90	
С	9.30	9.75	10.20	
E	5.30	5.80	6.30	
E3	4.50	5.15	5.80	
L	0.90	1.35	1.80	
Ll	2.00	2.53	3.05	
L2	0.50	0.85	1.20	
b	0.30	0.50	0.70	
bl	0.40	0.60	0.80	
A	2.10	2.30	2.50	
A2	0.40	0.53	0.65	
A1	0.00	0.10	0.20	
e	1.20	1.30	1.40	

- 1.All Dimensions Are in Millimeters.
- 2 Dimension Does Not Include Mold Protrusions.

**Package Marking and Ordering Information** 

Product ID	Pack	Marking	Qty(PCS)
TAPING	TO-252-4L		2500

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